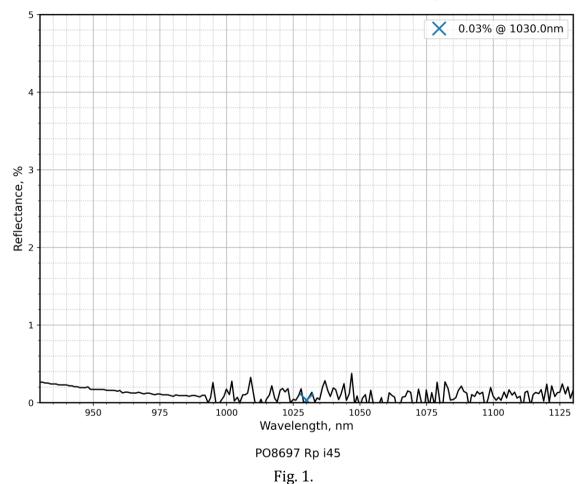


YOUR SIDEKICK FOR LASER OPTICS DEVELOPMENT

S1: ARp < 0.1% @ 1030 nm, AOI 45 deg S2: ARp < 0.1% @ 1030 nm, AOI 45 deg



SIDE MEASURED: S1 only (grinded witness sample)

COMMENTS:



YOUR SIDEKICK FOR LASER OPTICS DEVELOPMENT

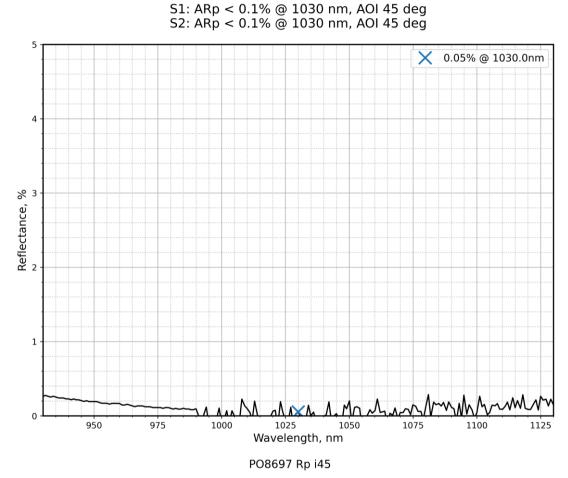


Fig. 2.

SIDE MEASURED: S2 only (grinded witness sample)

COMMENTS: